

Notice of References Cited	Application/Control No. 10/696,997		Applicant(s)/Patent Under Reexamination LEE, JAE-CHEOL	
	Examiner SIU M. LEE		Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,259,740	03-1981	Snell et al.	375/346
*	B	US-7,280,586 B2	10-2007	Tanaka, Katsuyuki	375/150
*	C	US-2005/0053048 A1	03-2005	Van Der Wal et al.	370/350
*	D	US-5,999,561	12-1999	Naden et al.	375/142
*	E	US-6,778,588 B2	08-2004	Li et al.	375/130
*	F	US-6,717,996 B1	04-2004	Du Reau et al.	375/343
*	G	US-2002/0025006 A1	02-2002	Mehrnia et al.	375/316
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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